

where the electric field from the interferometer $E(t, \tau)$ is

$$E(t, \tau) = \frac{1}{2\pi} \int E_0(\omega) \cdot \tilde{t}(\omega, \tau) \cdot e^{i\omega t} d\omega \quad (9)$$

$$E_0(\omega) = \int E_0(t) \cdot e^{-i\omega t} dt, \quad (10)$$

where $E_0(\omega)$ is the initial electric field in frequency domain and $\tilde{t}(\omega, \tau)$ is the complex amplitude transfer function as a kernel of inverse Fourier transform. By using the dynamic matrix [12,13], one can derive the transfer function for each interferometer as follows:

$$\tilde{t}_M(\omega, \tau) = r \cdot t \cdot (e^{-i\omega\tau_0} - e^{-i\omega\tau}) \quad (11)$$

$$\tilde{t}_{FP2}(\omega, \tau) = t^2 \cdot e^{-i\omega\tau/2} / (1 - r^2 \cdot e^{-i\omega\tau}) \quad (12)$$

$$\tilde{t}_{FP3}(\omega, \tau) = t^3 \cdot e^{-i\omega(\tau+\tau_0)/2} / \{1 - r^2(e^{-i\omega\tau} + e^{-i\omega\tau_0} - e^{-i\omega(\tau+\tau_0)})\}, \quad (13)$$

where \tilde{t}_M , \tilde{t}_{FP2} and \tilde{t}_{FP3} are the transfer functions for a Michelson interferometer, a Fabry-Perot interferometer with two and three interfaces, respectively. r and t are the reflection and transmission coefficients where $|r|^2 + |t|^2 = 1$. ω is the angular frequency and τ is an optical delay, defined as $\tau = 2n_0d/c$. n_0 is the refractive index of the air and c is the speed of light. d is the distance between a beam splitter and a delay mirror for a Michelson interferometer or it is the distance between two etalons for a Fabry-Perot interferometer, as shown in Fig. 5. τ_0 is the reference delay which is defined as $\tau_0 = 2n_gd_0/c$, where n_g is the group index of a reference medium, which corresponds to the substrate material of etalons for a Fabry-Perot interferometer or the air for a Michelson interferometer. d_0 is the thickness of an etalon for a Fabry-Perot interferometer or the distance between a beam splitter and a reference mirror for a Michelson interferometer.

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